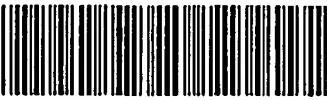


<b>Search Notes</b> 				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/713,714	RENNER ET AL.	
				Examiner	Art Unit	
				M. Lee	2622	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
348	547, 536, 537, 529, 511	6/10/2006	ML	EAST	6/10/2006	ML
375	376	1/130/06	ML	<i>updated</i>	1/130/06	ML
327	159, 157					
	156					
331	179					
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			